

**Search Notes**

Application/Control No.

10/676,025

Examiner

Paul D. Kim

Applicant(s)/Patent under  
Reexamination

YEOM ET AL.

Art Unit

3729

**SEARCHED**

Class	Subclass	Date	Examiner
29	603.03	6/13/2006	PK
	729		
	737		
	757		
	759		
360	760		
	98.07	↓	
	98.0		
	99.08		
	99.1		
	568		
33	552		
	180	✓	

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Text Search EAST/NPL (IEEE)	6/13/2006	PK
Reviewed Relative Application 10/676,144 10/676,145	6/13/2006	PK
Updated Text Search EAST	6/14/2006	PK
Updated Text Search EAST	12/5/2006	PK
Updated Text Search EAST	4/23/2007	PK